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Carly Sun 10Gtek Transceivers Co. Ltd info@10gtek.com July 5, 2018

Enclosed are the results from the Open Network Systems Interoperability performed on:

Module or Cable Assembly Under Test (MUT/CUT):

Vendor and Device Type	10Gtek SFP+	
Part Number	CAB-10GSFP-P3M	

### Host Under Test (HUT):

Host ender rest (He I).				
Host System 1 Composition				
Network Operating System	Cumulus			
OS Version	3.4			
Bare Metal Switch	Edge-Core 5712			
Part Number	5712			
ONIE Version	2018.02			

This testing pertains to the Open Network Systems Interoperability Test Plan, which outlines a series of tests performed on a variety of optical transceivers and cables with bare-metal open switches running Network Operating Systems from multiple vendors. The focus of these tests was basic interoperability, which aims to validate the operation of open network systems.

As always, we welcome any comments regarding this Test Suite. If you have any questions about the test procedures or results, please feel free to contact me via e-mail at <a href="mailto:david@iol.unh.edu">david@iol.unh.edu</a> or by phone at +1-603-862-0090.

Regards, David Woolf

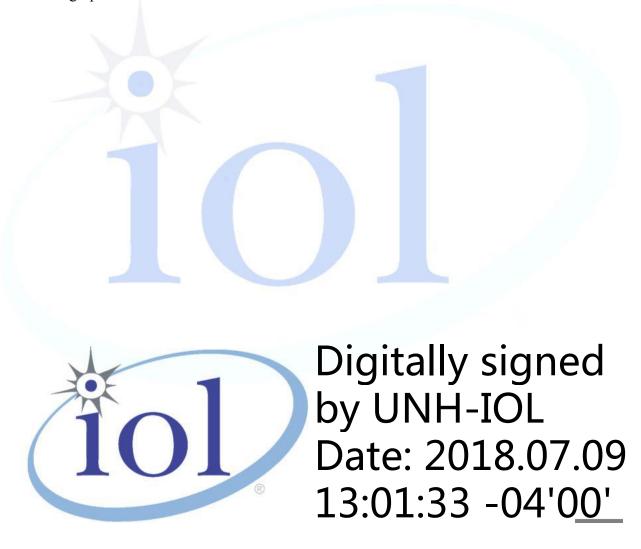
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In section 2, the following equipment was used:

Test System Hardware	
EEPROM Reader	I2C Elite Reader

In section 3, the following equipment was used:

Test System Hardware	
Network Analyzer	PNA –Performance Network Analyzer

In section 4, the following equipment was used:

Test System Hardware			
Wide Bandwidth	Keysight DCA-X 86100D Wide Bandwidth Oscilloscope		
Oscilloscope			
Waveform Analyzer	Keysight 86105C Optical Waveform Analyzer		
50GHz Waveform	Keysight 86108B Mega Module, 50GHz Bandwidth Waveform		
Analyzer	Analyzer		
	Allaryzei		
Clock Recovery Module	Keysight 83496B Optical/Electrical Clock Data Recovery Unit		
High Performance Serial	Tektronix BERTScope		
BERT			
Signal Quality Analyzer	BERTScope PRBS9 at 10.3125Gbps		
De-Emphasis Signal	Agilent N4916B		
Converter			

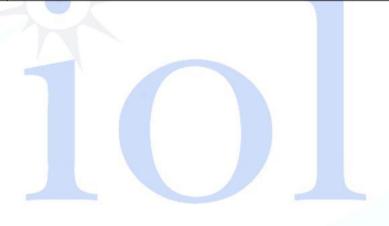
<sup>\*</sup>Two modules used during testing

In section 6, an MLNK NICS was used to generate test traffic:

Test System Hardware				
Ethernet Traffic Generator	MLNK NICS			
Software Version	Ostinato			
Port Types	10G SFP			

The following table contains possible results and their meanings.

Result	Interpretation
PASS	The Device Under Test (DUT) was observed to exhibit conformant behavior.
PASS W/ Comments	The specified behavior is demonstrated by the DUT; however this result indicates that either changes were made to the standard test procedure or results other than the expected results were observed.
FAIL	The DUT was observed to exhibit non-compliant behavior.
INFO	This Test is designed for informational purposes only. While the results may help ensure the interoperability of the DUT, a PASS/FAIL is not given for this test.
WARN	The DUT was observed to exhibit behavior that is not recommended.
N/A	Not Applicable. This test is not applicable for the DUT.
N/S	Not Supported. This test was not run due to features not implemented on the DUT.
N/T	Not tested. This test was not run.



Cumulus 3.4 | Accton 5712 | 10Gtek Transceivers Co. Ltd CAB-10GSFP-P3M Open Network Systems Interoperability Test Report

Summary of Results- Conformance				
Test	Result			
Test 1.1:	N/A			
Test 1.2:	PASS			
Test 3.1.1: Return Loss for 10G Passive Cable	PASS			
Test 3.1.2: Insertion Loss for 10G Passive Cable	PASS			
Test 5.1.1: Output Rise and Fall Times for 100G Host	PASS			
Test 5.1.2: Transmitter Eye Mask for 100G Host	PASS			
Test 5.1.3: Total Jitter for 100G Host	PASS			
Test 5.1.4: Input and Output Return Loss on 100G Host	PASS			

Summary of Results - Interoperability				
Test	Result			
Test 2.1: Physical Compatibility with Supporting Devices	PASS			
Test 2.2: Host Management of Module or Cable Assembly	PASS			
Test 2.3: Diagnostic Optical Monitor Support	PASS			
Test 6.1: Establish Baseline Performance Analysis	PASS			
Test 6.2:	PASS			
Test 6.3:Packet Error Rate Estimation	PASS			
Test 6.4: Packet Loss/Stress Test	PASS			

Notes						

Test Information	Test Result
Test 1.1:	
<i>Purpose</i> : To verify that a host can pass a random sampling of ONIE Compliance Environment tests.	N/A
Comments on Test Procedure	21
The random sampling of tests from the ONIE Compliance Environment was not used.  Comments on Test Results	
Additional Comments	
This test is only applicable to Hosts which have not performed ONIE compliance previously.	ance testing

Test Information	Test Result
Test 1.2:	PASS
Purpose: To verify that a NOS can be successfully installed through ONIE.	rass
Comments on Test Procedure	
This test was completed using the standard procedure as written in the Test Pla the ONIE Compliance Environment was not used.  Comments on Test Results	n. The random sampling of tests from
Comments on Test Results	
<ul><li>Part A: The DUT was able to install the NOS via ONIE.</li><li>Part B: The DUT was able to uninstall the NOS via ONIE.</li></ul>	
Additional Comments	

Test Information	Test Result
Test 3.1.1: Return loss for 10G Passive Cable	
<i>Purpose</i> : To verify that the return loss of the DUT is within the conformance limits provided by SFF-8431 Appendix E, Table 37.	PASS

### **Comments on Test Procedure**

This test was completed using the standard procedure.

### **Comments on Test Results**

The differential return loss observed did not violate the limits governed by SFF-8431 Appendix E.4, Table 37 for 10GBASE-CR passive cables:

$$12 - 2\sqrt{\phantom{0}}, \qquad 0.01 \le < 4.1$$

$$11, \qquad 22 \ge \{ \\ 6.3 - 13 \log_{10} 5.5, \qquad 4.1 \le \le 11.1 \} ( )$$

### **Additional Comments**

Test Information	Test Result
Test 3.1.2: Insertion Loss for 10G Passive Cable	
Purpose: To verify that the insertion loss of the Cable under test is within the conformance limits provided by IEEE Std. 802.3-2012 Annex, Table 37.	PASS

### **Comments on Test Procedure**

This test was completed using the standard procedure.

### **Comments on Test Results**

The insertion loss of the cable under test does not violate the requirements passive cable assemblies.

$$3 \leq 21, \quad 12 \leq 17.04, \quad 5.15625$$

### **Additional Comments**

Test Information	Test Result
Test 5.1.1: Output Rise and Fall Times for 10G Host	
Purpose: To verify that the Eye Mask Hit Ratio is within the conformance limits.	PASS
Comments on Test Procedure	- 4
The test was completed with the standard procedure.	
Comments on Test Results	
The device under test exhibited the expected behavior.	
Additional Comments	

Test Information	Test Result
Test 5.1.2: <b>Transmitter Eye Mask on 10G Host</b> Purpose: To verify that the Eye Mask Hit Ratio is within the conformance limits.	PASS
Comments on Test Procedure	
The test was completed with the standard procedure.  Comments on Test Results  The device under test exhibited the expected behavior.	
Additional Comments	
	,

Test Information	Test Result
Test 5.1.3:  Purpose: To verify that the Total Jitter (TJ) is within the conformance limit.	PASS
Comments on Test Procedure	1
The test was completed with the standard procedure.	
Comments on Test Results	
The device under test exhibited the expected behavior.	
Additional Comments	

Test Information	Test Result
Test 5.1.4: Input and Output Return Loss on 10G Host	
Purpose: To verify that the differential input and output return loss of the DUT is within conformance limits.	PASS
Comments on Test Procedure	
The test was completed with the standard procedure.	
Comments on Test Results	
The device under test exhibited the expected behavior.	
Additional Comments	
See Appendix B	

Interoperability Test Results	
Test Information	Test Result
Test 2.1: Physical Compatibility with Supporting Devices	
<i>Purpose</i> : To verify that the mechanical form factor is compatible with devices for interoperability purposes.	PASS
Comments on Test Procedure	
The test was completed with the standard procedure.  Comments on Test Results	
Part A: The MUT/CUT was able to be inserted into the Host.  Part B: This test is not applicable to Cable Assemblies.  Part C: The MUT/CUT was able to be removed from the Host.	
Additional Comments	

Test Information	Test Result
Test 2.2:  Purpose: To verify that the MUT/CUT is manageable via the Host complex.	PASS
Comments on Test Procedure	
The test was completed with the standard procedure.	
Comments on Test Results	
<b>Part B:</b> The EEPROM data of the MUT/CUT was readable. The serial number and ventor the EEPROM data matches the serial number and vendor information of	
Additional Comments	

Test Information	Test Result
Test 2.3:	
<i>Purpose</i> : To verify that the MUT/CUT (active optical cable only) supports diagnostic functions via the Host complex.	PASS
Comments on Test Procedure	
The test was completed with the standard procedure.  Comments on Test Results	
Part A: The MUT/CUT supports diagnostic monitoring and the diagnostic information fr readable by the NOS.	om the EEPROM was
Additional Comments	

Test Information	Test Result
Test 6.1: <b>Establish Baseline Performance Analysis</b> Purpose: To establish a baseline performance analysis of the HUT.	PASS
Comments on Test Procedure	

This test was completed using a modified procedure. Because of a lack of 40G Golden Modules, the Host was baselined using each 40G MUT/CUT.

#### **Comments on Test Results**

The baseline performance of the Host was determined to be 90% line rate. All proceeding tests in Group 6 were conducted using this line rate.

### **Additional Comments**

Test Information		Test Result
Test 6.2:		
D T 14 ' 'C4	MITOUT HIT IID (1111 111 111 111 111	PASS
1	MUT/CUT, HUT and LP establish a link while varying the	
power up sequence.		

### **Comments on Test Procedure**

This test was completed using the standard procedure.

#### **Comments on Test Results**

- **Part A:** The Host and Link Partner were able to establish a valid link with this MUT/CUT while fully powered and operational.
- **Part B:** The Host and Link Partner were able to establish a valid link with this MUT/CUT when the Link Partner was powered on after the Host.
- **Part C:** The Host and Link Partner were able to establish a valid link with this MUT/CUT when the Host was powered on after the Link Partner.

### **Additional Comments**

Test Information	Test Result
Test 6.3:Packet Error Rate Estimation	PASS
Purpose: To determine if a Host can exchange packets with a Module or Cable Assembly such that a bit error rate of 10 <sup>-12</sup> is achieved	TASS
Comments on Test Procedure	
This test was completed using the standard procedure.	
Comments on Test Results	
Part A: All 247,000,000 frames transmitted by TS1 were received by TS2.  Part B: All 10,506,539,320 frames transmitted by TS1 were received by TS2.	
Additional Comments	

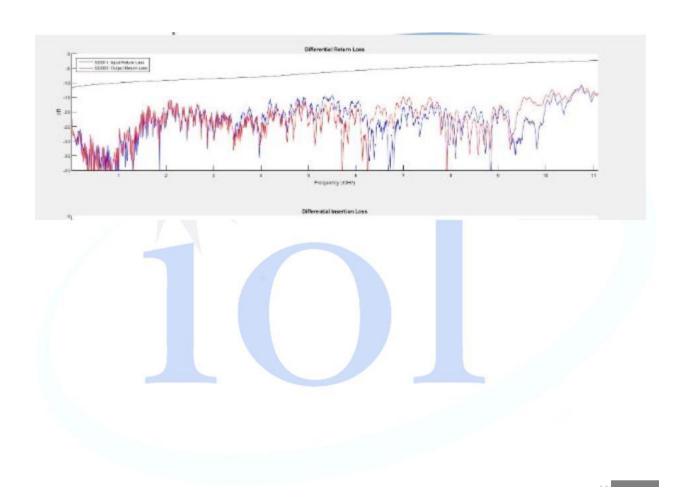
Test Information		Test Result
Test 6.4: Packet Loss/Stress Test  Purpose: To verify that no obvious buffer management problems occur when di large volume of traffic at the Host and Module/Cable Assembly combination.	recting a	PASS
Comments on Test Procedure		
This test was completed using the standard procedure.		
Comments on Test Results		
Parts A-D: All 1,000,000,000 64-byte frames transmitted by TS1 were received by TS2. All 1,000,000,000 1518-byte frames transmitted by TS1 were received by TS2.		
Additional Comments		

### **Appendix A: EEPROM Data**

```
10Gtek SFP/SFP+/SFP28 module
Part Number: CAB-10GSFP-P3M Serial Number: WTS31HA0058
10Gtek WTS31HA0058 EEPROMdecode 20180530194410.txt
SERIAL ID Keys:
BR MAX: 10300
BR MIN: 10300
BR NOMINAL: 10300
CABLE SPEC: 0x0 0x0
CONNECTOR: 33
DATE_CODE: 171001
DIAGNOSTIC MONITORING TYPE: 0
ENCODING: 0
ENHANCED OPTIONS: 0
EXT IDENTIFIER: 4
IDENTIFIER: 3
LENGTH 50UM: 0
LENGTH 62 5UM: 0
LENGTH OM3: 0
LENGTH OM4 OR CU: 128
LENGTH SMF: 0
LENGTH SMF KM: 0
OPTIONS: 0x0 0x0
RATE IDENTIFIER: 0
SFF 8472 COMPLIANCE: 8
TRANSCEIVER: 0x1 0x0 0x0 0x4 0x41 0x84 0x80 0xd5
TRANSCEIVER EXT: 0
VENDOR NAME: 10Gtek
VENDOR OUI: 0x0 0x0 0x0
VENDOR PN: CAB-10GSFP-P3M
VENDOR REV: V01
VENDOR SN: WTS31HA0058
WAVELENGTH: 0
0x00x
I2C Address A0h, bytes 0-127, in hex
0000x: 03042101 00000441 8480d500 67000000
0010x: 00000300 31304774 656b2020 20202020
0020x: 20202020 00000000 4341422d 31304753
0030x: 46502d50 334d2020 56303120 00000075
0040x: 00000000 57545333 31484130 30353820
0050x: 20202020 31373130 30312020 000008ca
0060x: 00000000 00000000 00000000 00000000
0070x: 00000000 00000000 00000000 00000000
I2C Address A2h, bytes 0-127, in hex
0010x: 00000000 00000000 00000000 00000000
0020x: 00000000 00000000 00000000 00000000
0030x: 00000000 00000000 00000000 00000000
0040x: 00000000 00000000 00000000 00000000
0050x: 00000000 00000000 00000000 00000000
0060x: 00000000 00000000 00000000 00000000
                                                              K: K:
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0070x: 00000000 00000000 00000000 00000000

**Appendix B: Pluggable Module / Cable Electrical Data** 



## **Appendix C: Host Electrical Data**

